

Notice of References Cited

Applicant/Patent
Wakamiya et al

Application/Control No.
09/818,906

Examiner
Nitin Parekh

Art Unit
2811

Page 1 of 1

U.S. PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
X	A	5,952,718	9/1999	Ohtsuka et al	257	737
X	B	5,641,996	6/1997	Omoya et al	257	787
X	C	5,866,920	2/1999	Matsumoto et al	257	63
X	D	5,981,313	11/1999	Tanaka	438	118
	E					
	F					
	G					
	H					
	I					
	J					
	K					
	L					
	M					

FOREIGN PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Country	Name	Classification ²	
	N						
	O						
	P						
	Q						
	R						
	S						
	T						

NON-PATENT DOCUMENTS

		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages					
	U						
	V						
	W						
	X						

* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.

² Classifications may be U.S. or foreign.

Notice of References CitedApplication/Control No.
09/818,906Applicant(s)/Patent Under Reexam
Wakamiya et alExaminer
Nitin ParekhArt Unit
2811

Page 1 of 1

U.S. PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
X	A	6,181,569	1/2001	Chakravorty	361	761
	B					
	C					
	D					
	E					
	F					
	G					
	H					
	I					
	J					
	K					
	L					
	M					

FOREIGN PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Country	Name	Classification ²	
	N						
	O						
	P						
	Q						
	R						
	S						
	T						

NON-PATENT DOCUMENTS

		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
	U	
	V	
	W	
	X	

* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.

² Classifications may be U.S. or foreign.